

5SJA 3000L520300

StakPak BIGT Module

 $V_{CE} = 5200 \text{ V}$
 $I_C = 3000 \text{ A}$

Low-loss, rugged BIGT chip

Optimized for low switching frequency

Smooth switching for good EMC

High tolerance to uneven mounting pressure

Explosion resistant package

Remains in low impedance state for up to 1 minute after failure*



Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	max	Unit
Collector-emitter voltage	V_{CES}	$V_{GE} = 0 \text{ V}$, $T_{vj} \geq 25 \text{ °C}$		5200	V
DC collector current	I_C	$T_C = 108 \text{ °C}$, $T_{vj} = 125 \text{ °C}$		3000	A
Peak collector current	I_{CM}	$t_p = 1 \text{ ms}$		6000	A
Gate-emitter voltage	V_{GES}		-20	20	V
Total power dissipation	P_{tot}	$T_C = 25 \text{ °C}$, $T_{vj} = 125 \text{ °C}$		55500	W
DC forward current	I_F			3000	A
Peak forward current	I_{FRM}	$t_p = 1 \text{ ms}$		6000	A
Peak diode recovery power	P_{prec}	$V_{CC} \leq 3400 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 5200 \text{ V}$, $T_{vj} = 125 \text{ °C}$, $di/dt = 7.5 \text{ kA}/\mu\text{s}$, $L_G = 150 \text{ nH}$, inductive load		7.5	MW
Surge current	I_{FSM}	$V_R = 0 \text{ V}$, $T_{vj} = 125 \text{ °C}$, $V_{GE} = 0 \text{ V}$, $t_p = 10 \text{ ms}$, half-sinewave, 3 times during lifetime		42000	A
BIGT turn off SOA (IGBT mode)	RBSOA	$V_{CC} \leq 3400 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 5200 \text{ V}$, $T_{vj} = 125 \text{ °C}$, $V_{GE} = 15 \text{ V}$, $R_G = 1.2 \Omega$, $C_{GE} = 330 \text{ nF}$, $L_G = 150 \text{ nH}$, inductive load		6000	A
BIGT turn off SOA (IGBT mode)	RBSOA	$V_{CC} \leq 3800 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 5200 \text{ V}$, $T_{vj} = 125 \text{ °C}$, $V_{GE} = 15 \text{ V}$, $R_G = 1.2 \Omega$, $C_{GE} = 330 \text{ nF}$, $L_G = 150 \text{ nH}$, inductive load		3000	A
BIGT short circuit SOA	t_{psc}	$V_{CC} = 3400 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 5200 \text{ V}$ $V_{GE} \leq 15 \text{ V}$, $T_{vj} \leq 125 \text{ °C}$		10	μs
Junction temperature	T_{vj}		5	150	°C
Junction operating temperature	$T_{vj(op)}$		5	125	°C
Case temperature	T_C		5	70	°C
Storage temperature	T_{stg}		-40	70	°C
Mounting force ^{2) 3)}	F_M		60	90	kN

¹⁾ Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747

²⁾ For detailed mounting instructions refer to ABB document no. 5SYA 2037-02

³⁾ All electrical characteristics are valid only when the module is clamped

* Functionality is load profile dependent and needs to be agreed upon

IGBT characteristic values ⁴⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Collector (-emitter) breakdown voltage	$V_{(BR)CES}$	$V_{GE} = 0 \text{ V}$, $I_C = 10 \text{ mA}$, $T_{vj} = 25 \text{ }^{\circ}\text{C}$	5200			V
Collector-emitter ⁵⁾ saturation voltage	$V_{CE \text{ sat}}$	$I_C = 3000 \text{ A}$, $V_{GE} = 15 \text{ V}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	2.73		V
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	3.13		V
Collector cut-off current	I_{CES}	$V_{CE} = 5200 \text{ V}$, $V_{GE} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$		1	mA
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	60	120	mA
Gate leakage current	I_{GES}	$V_{CE} = 0 \text{ V}$, $V_{GE} = \pm 20 \text{ V}$, $T_{vj} = 25 \text{ }^{\circ}\text{C}$	-750		750	nA
Gate-emitter threshold voltage	$V_{GE(th)}$	$I_C = 480 \text{ mA}$, $V_{CE} = V_{GE}$, $T_{vj} = 25 \text{ }^{\circ}\text{C}$	5.2		7.2	V
Gate charge	Q_G	$I_C = 3000 \text{ A}$, $V_{CE} = 2800 \text{ V}$, $V_{GE} = -15 \text{ V} \dots 15 \text{ V}$		25.5		μC
Input capacitance	C_{ies}	$V_{CE} = 25 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 1 \text{ MHz}$, $T_{vj} = 25 \text{ }^{\circ}\text{C}$		439		nF
Output capacitance	C_{oes}			19.9		nF
Reverse transfer capacitance	C_{res}			30.0		nF
Internal gate resistor	R_{Gint}			0.104		Ω
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 2800 \text{ V}$, $I_C = 3000 \text{ A}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $V_{GE} = \pm 15 \text{ V}$, $L_{\sigma} = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	760		ns
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	880		ns
Rise time	t_r		$T_{vj} = 25 \text{ }^{\circ}\text{C}$	420		ns
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	420		ns
Turn-off delay time	$t_{d(off)}$	$V_{CC} = 2800 \text{ V}$, $I_C = 3000 \text{ A}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $V_{GE} = \pm 15 \text{ V}$, $L_{\sigma} = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	2760		ns
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	3040		ns
Fall time	t_f		$T_{vj} = 25 \text{ }^{\circ}\text{C}$	860		ns
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	980		ns
Turn-on switching energy	E_{on}	$V_{CC} = 2800 \text{ V}$, $I_C = 3000 \text{ A}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $V_{GE} = \pm 15 \text{ V}$, $L_{\sigma} = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	11100		mJ
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	14200		mJ
Turn-off switching energy	E_{off}	$V_{CC} = 2800 \text{ V}$, $I_C = 3000 \text{ A}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $V_{GE} = \pm 15 \text{ V}$, $L_{\sigma} = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	14100		mJ
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	18500		mJ
Short circuit current	I_{SC}	$t_{psc} \leq 10 \text{ } \mu\text{s}$, $V_{GE} = 15 \text{ V}$, $V_{CC} = 3400 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 5200 \text{ V}$	$T_{vj} = 125 \text{ }^{\circ}\text{C}$	18000		A

⁴⁾ Characteristic values according to IEC 60747 - 9

⁵⁾ Collector-emitter saturation voltage is given at chip level

Diode characteristic values ⁶⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Forward voltage ⁷⁾	V_F	$I_F = 3000 \text{ A}$, $V_{GE} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	2.29		V
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	2.52		V
		$I_F = 3000 \text{ A}$, $V_{GE} = 15 \text{ V}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	3.47		V
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	3.63		V
Peak reverse recovery current	I_{RM}	$V_{CC} = 2800 \text{ V}$, $I_F = 3000 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$, $R_G = 1.2 \text{ }\Omega$, $C_{GE} = 330 \text{ nF}$, $di/dt = 6.9 \text{ kA}/\mu\text{s}$ $L_G = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	3800		A
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	4500		A
Recovered charge	Q_r		$T_{vj} = 25 \text{ }^{\circ}\text{C}$	5100		μC
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	7600		μC
Reverse recovery time	t_{rr}		$T_{vj} = 25 \text{ }^{\circ}\text{C}$	2680		ns
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	2840		ns
Reverse recovery energy	E_{rec}		$T_{vj} = 25 \text{ }^{\circ}\text{C}$	9500		mJ
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	14500		mJ

⁶⁾ Characteristic values according to IEC 60747 - 2

⁷⁾ Forward voltage is given at chip level

Package properties

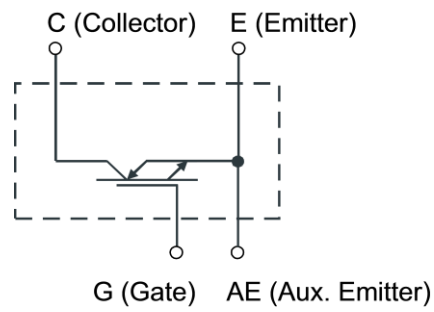
Parameter	Symbol	Conditions	min	typ	max	Unit
BIGT thermal resistance junction to case	$R_{th(j-c)IGBT}$				2.10	K/kW
BIGT thermal resistance ²⁾ case to heatsink	$R_{th(c-h)IGBT}$	Heatsink flatness : Complete module area < 100 μm Each submodule area < 20 μm Roughness : < 1.6 μm		0.55		K/kW
Comparative tracking index	CTI		600			

²⁾ for detailed mounting instructions refer to ABB Document No. 5SYA 2037-02

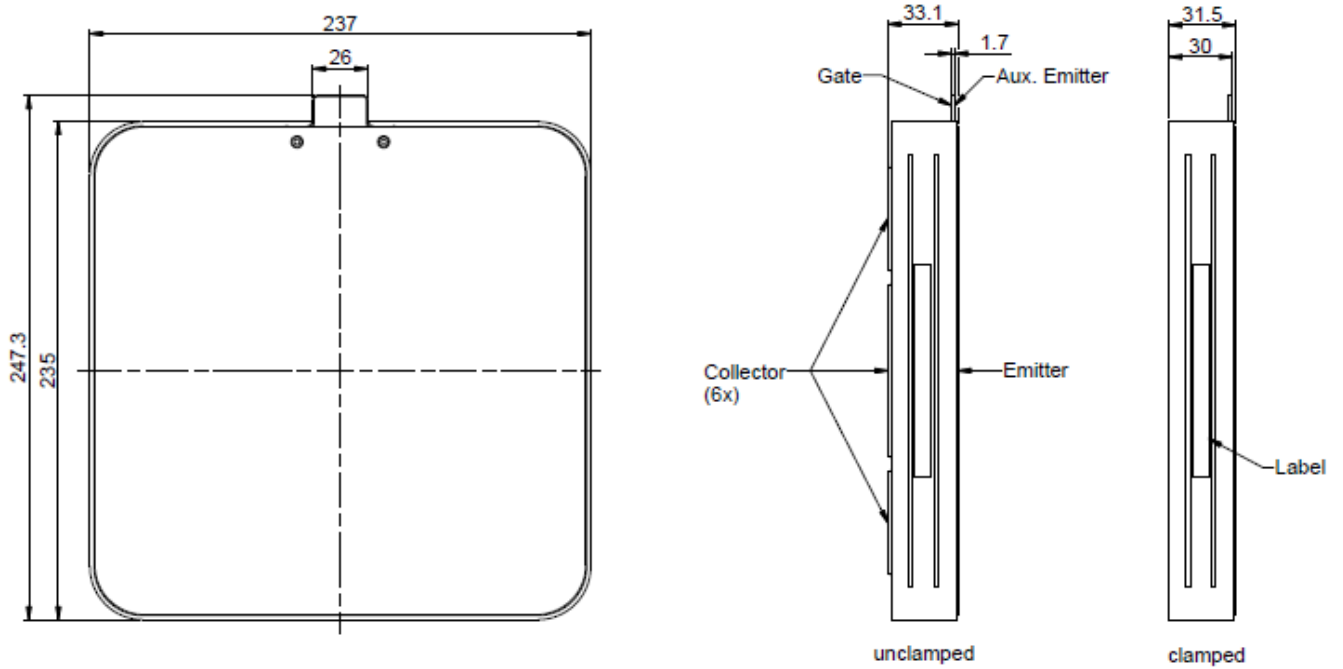
Mechanical properties

Parameter	Symbol	Conditions		min	typ	max	Unit
Dimensions	L x W x H	Typical	device clamped	237 x 250 x 31.5			mm
			device unclamped	237 x 250 x 33.2			
Clearance distance in air	d _a	according to IEC 60664-1 and EN 50124-1		23			mm
Surface creepage distance	d _s	according to IEC 60664-1 and EN 50124-1		30			mm
Mass	m				4030		g

Electrical configuration



Outline drawing ²⁾



Note: all dimensions are shown in millimeters

²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA 2039

This is an electrostatic sensitive device; please observe the international standard IEC 60747-1, chap. VIII.
This product has been designed and qualified for Industrial Level.

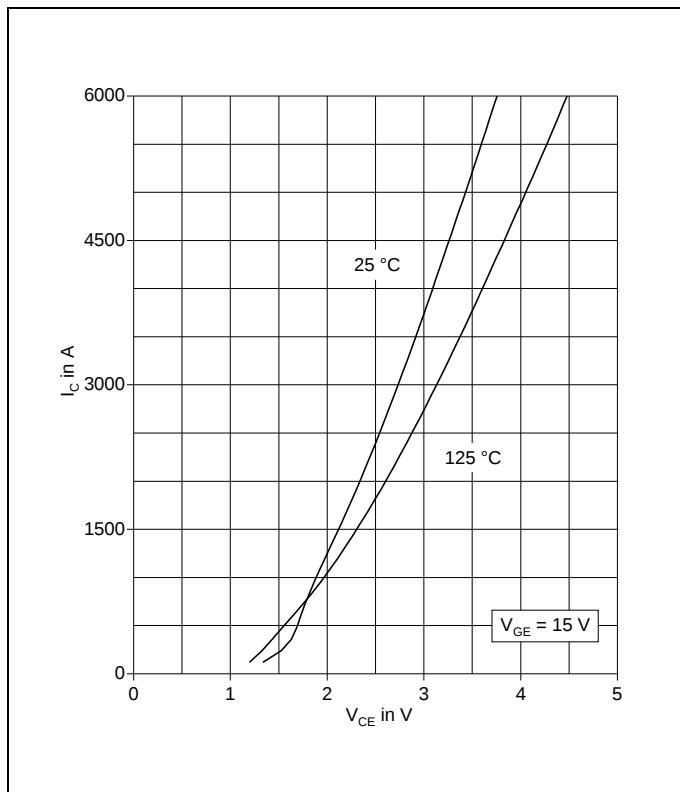


Fig. 1 Typical on-state characteristics, chip level

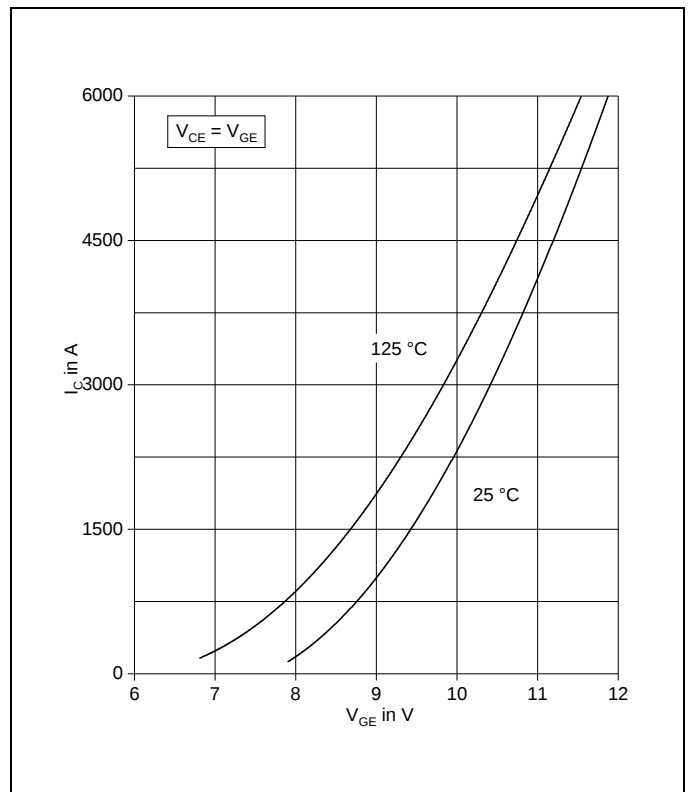


Fig. 2 Typical transfer characteristics, chip level

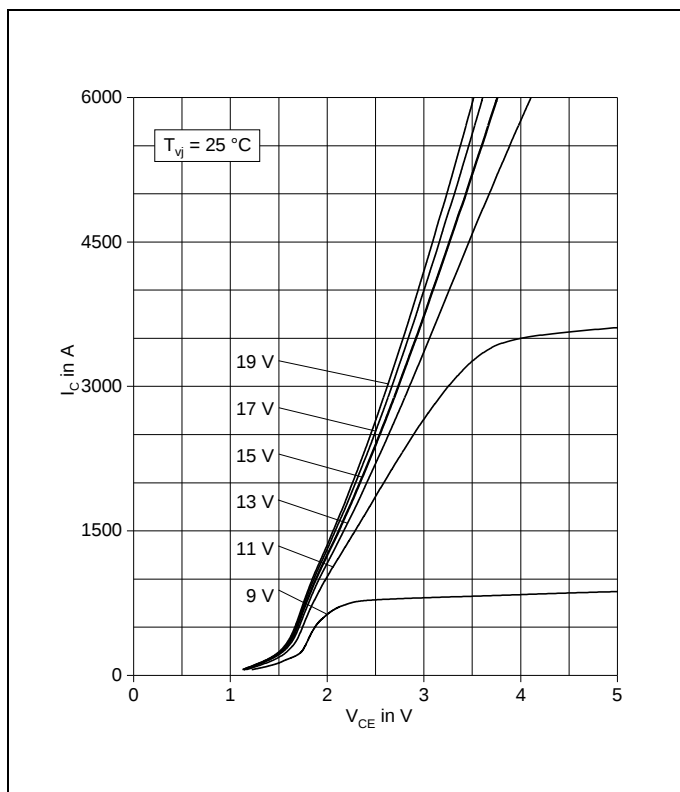


Fig. 3 Typical output characteristics, chip level

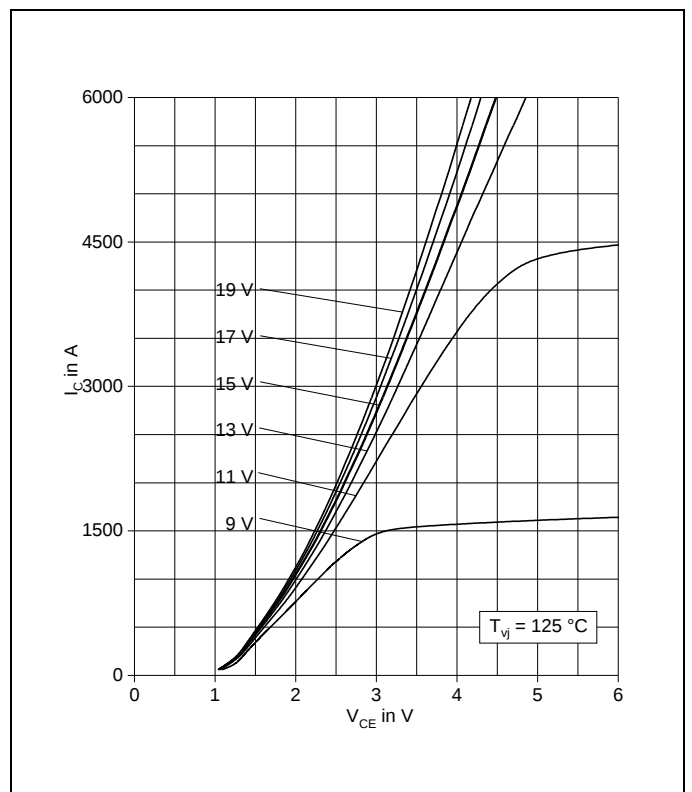


Fig. 4 Typical output characteristics, chip level

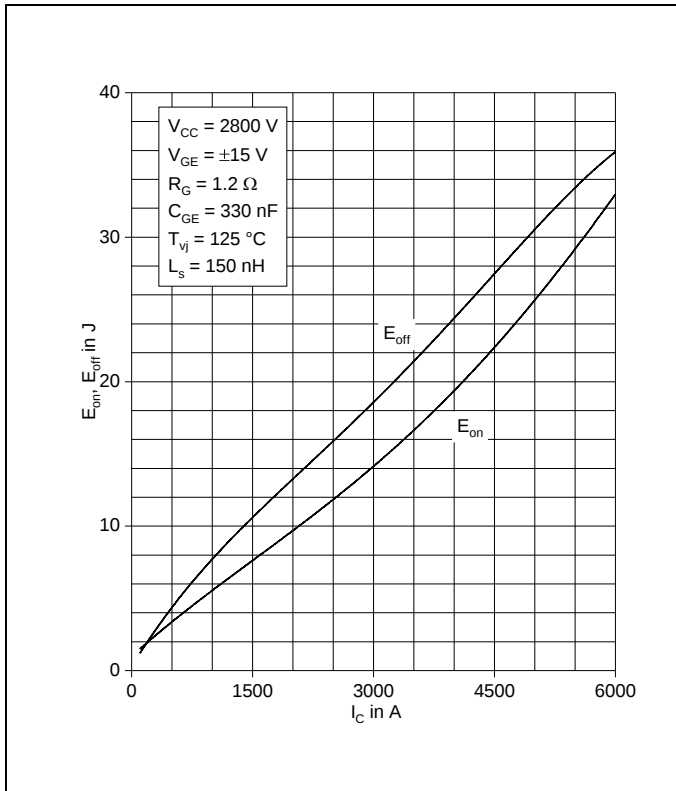


Fig. 5 Typical switching energies per pulse vs. collector current

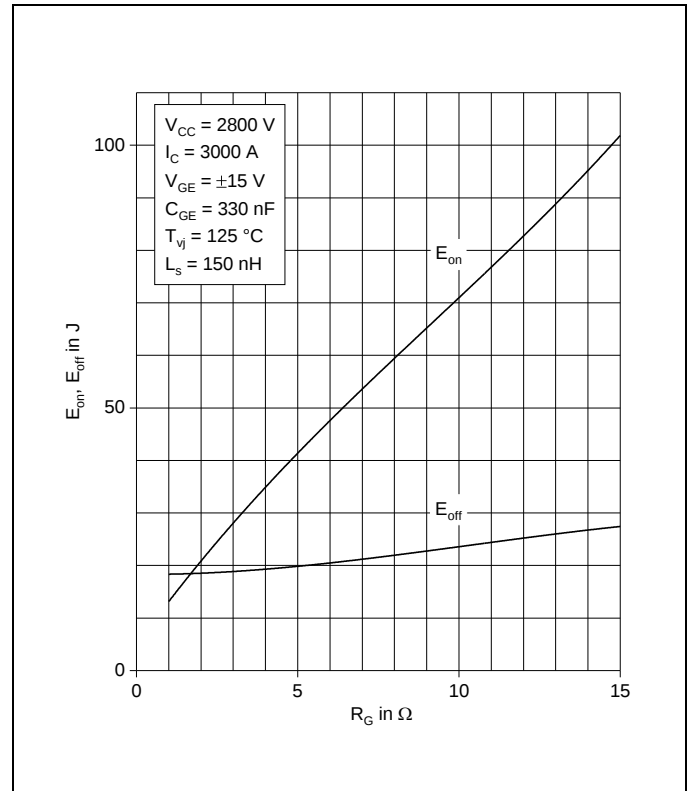


Fig. 6 Typical switching energies per pulse vs. gate resistor

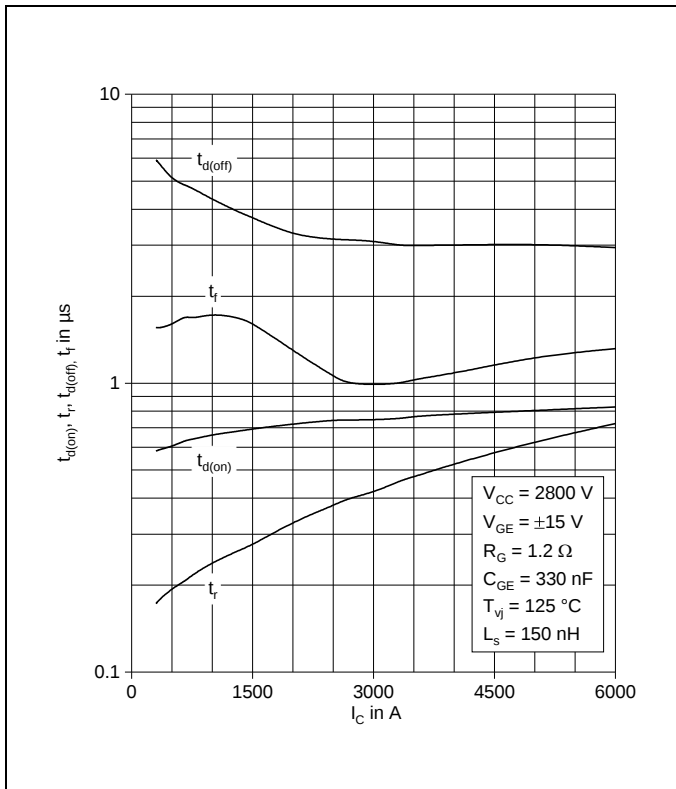


Fig. 7 Typical switching times vs. collector current

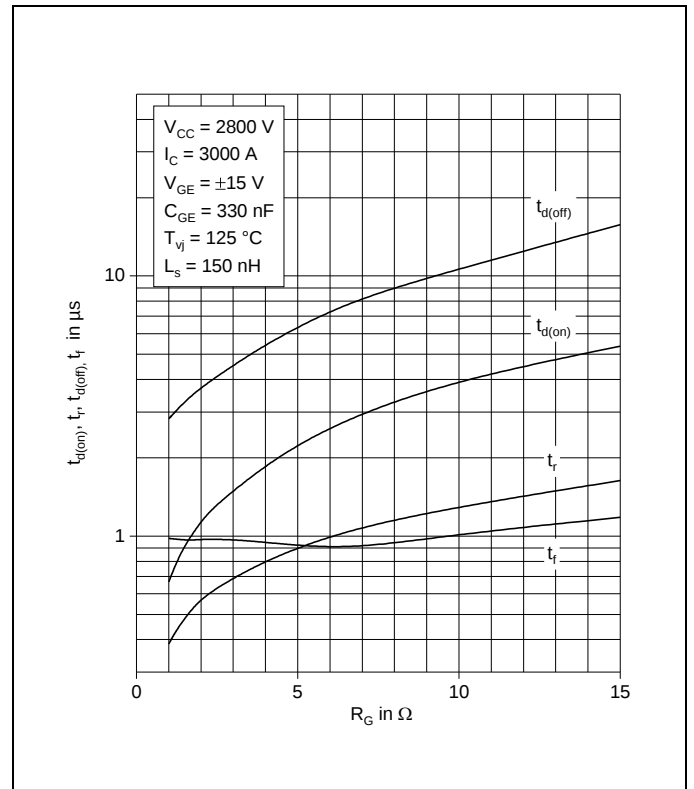


Fig. 8 Typical switching times vs. gate resistor

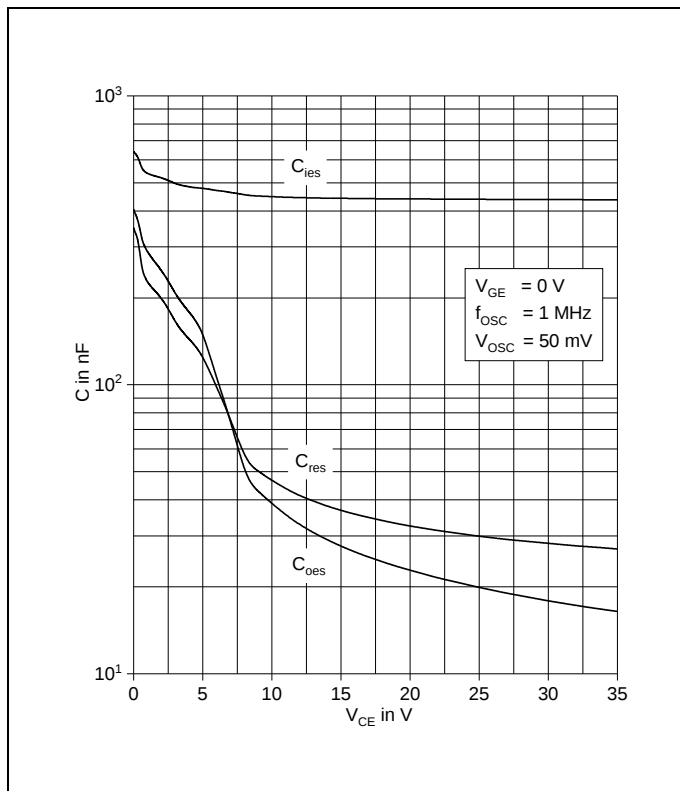


Fig. 9 Typical capacitances vs. collector-emitter voltage

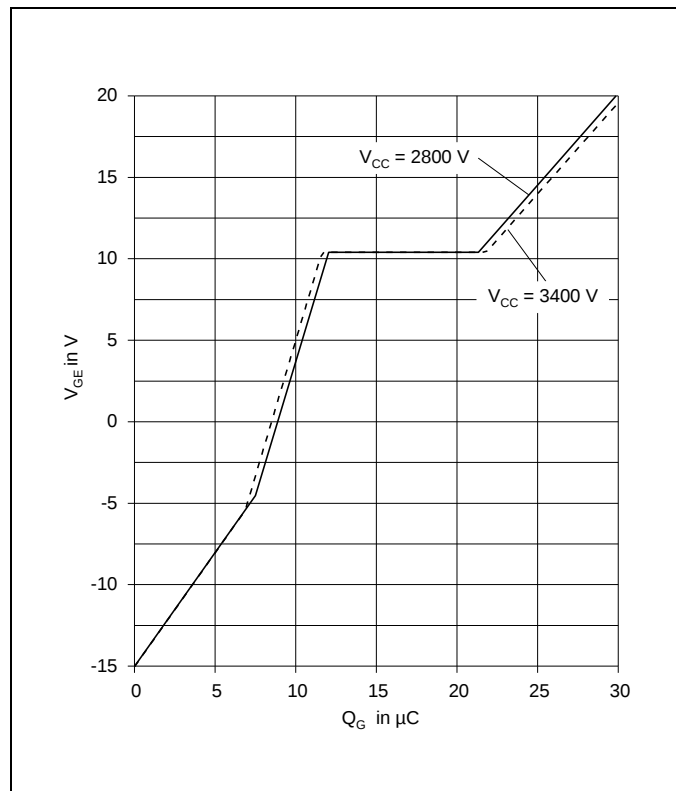


Fig. 10 Typical gate charge characteristics

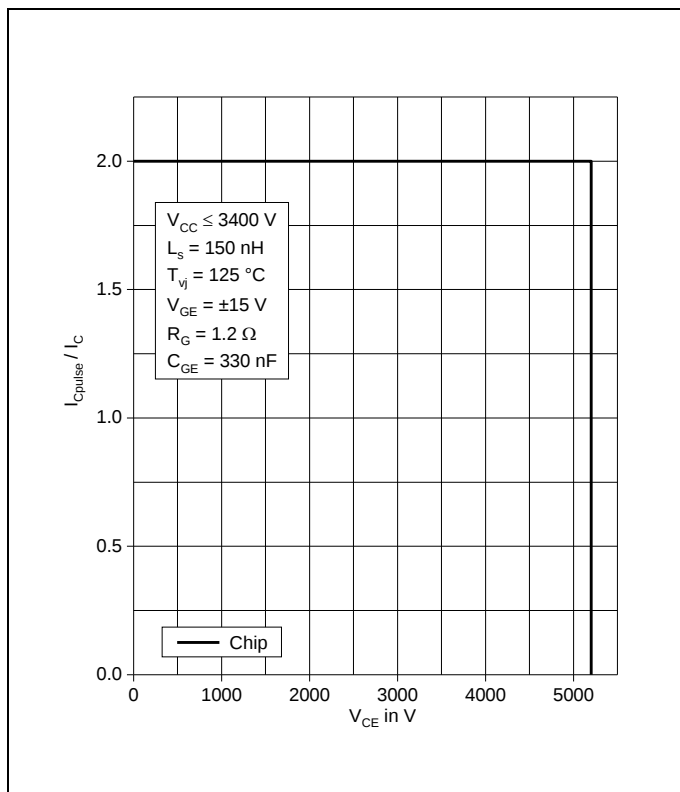


Fig. 11 Turn-off safe operating area (RBSOA)

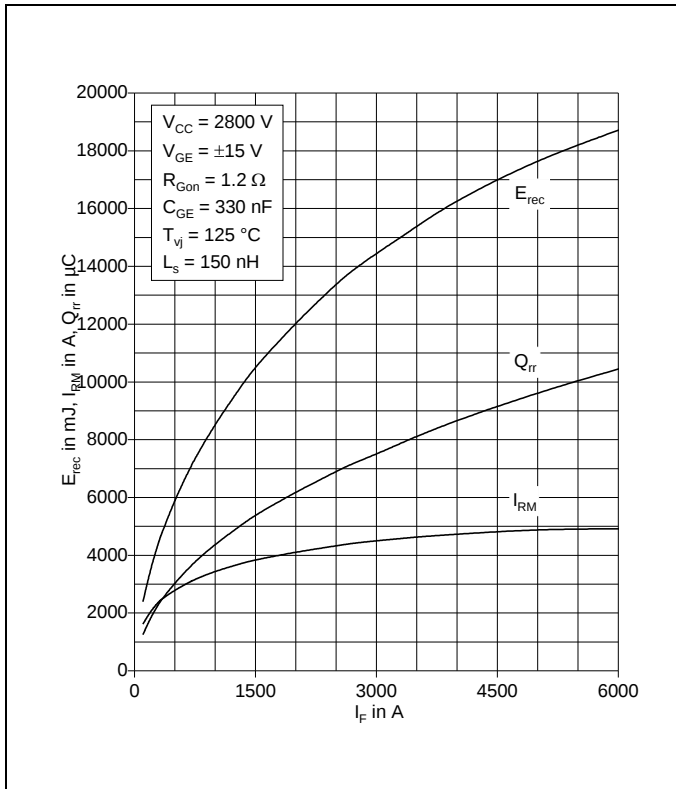


Fig. 12 Typical reverse recovery characteristics vs. forward current

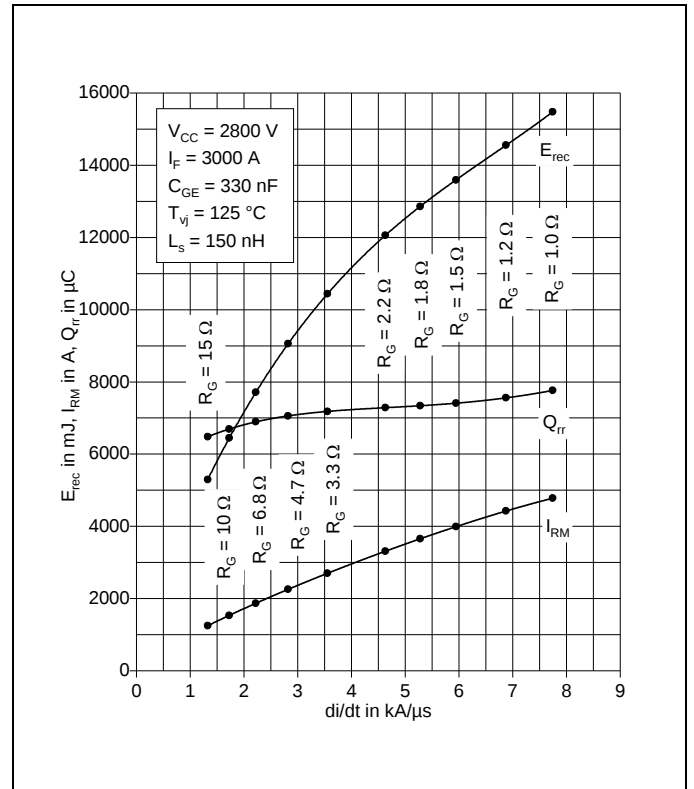


Fig. 13 Typical reverse recovery characteristics vs. di/dt

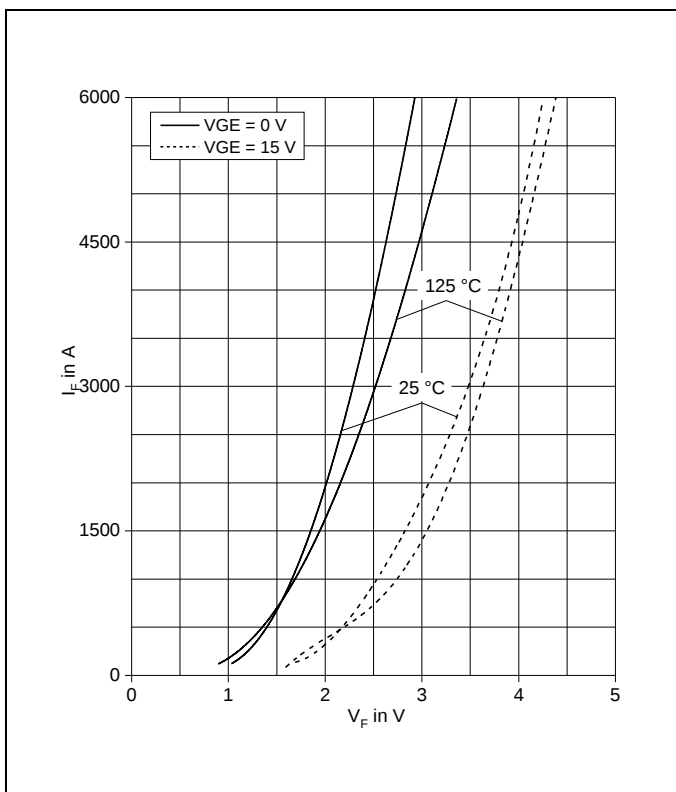


Fig. 14 Typical diode forward characteristics chip level

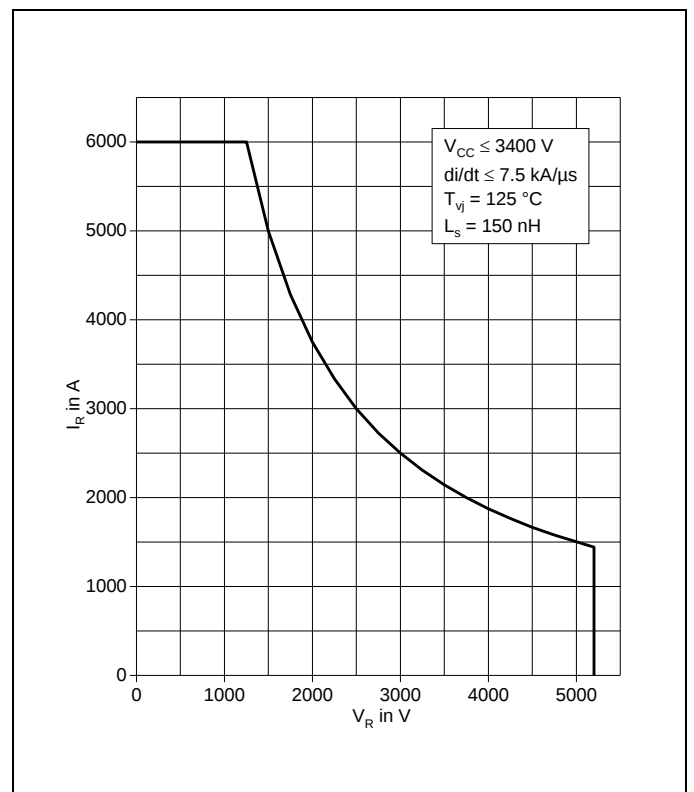


Fig. 15 Safe operating area diode (SOA)

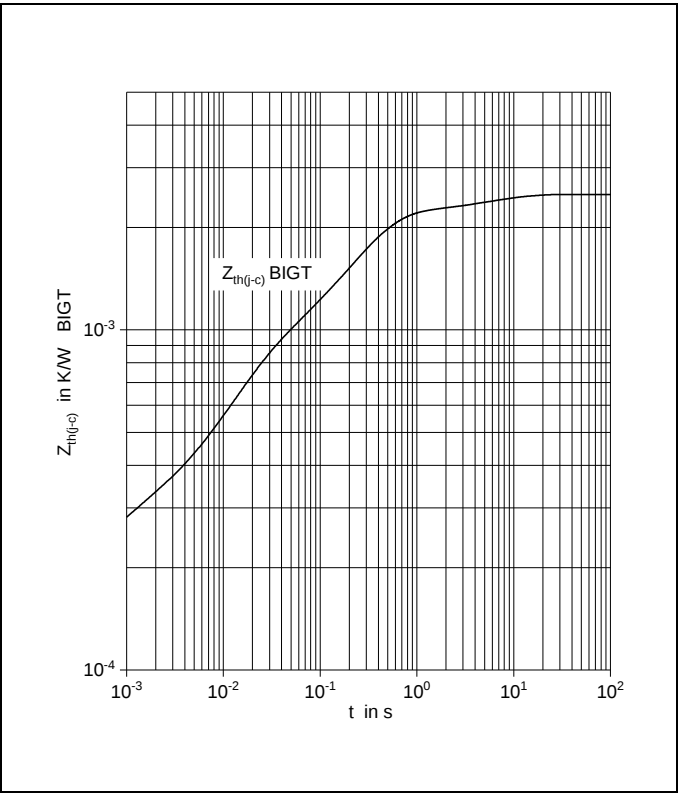


Fig. 16 Thermal impedance vs. time

Analytical function for transient thermal impedance:

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i (1 - e^{-t/\tau_i})$$

i	1	2	3	4
R _i in K/kW	0.265	0.546	1.393	0.299
τ _i in s	0.0004	0.0168	0.2862	6.0189

Related documents:

- 5SYA 2045 Thermal runaway during blocking
- 5SYA 2053 Applying IGBT
- 5SYA 2093 Thermal design of IGBT modules

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